Date/Time: 7/28/2005 12:27:55 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 824.7 MHz;Duty Cycle: 1:1.08
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 97.1 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

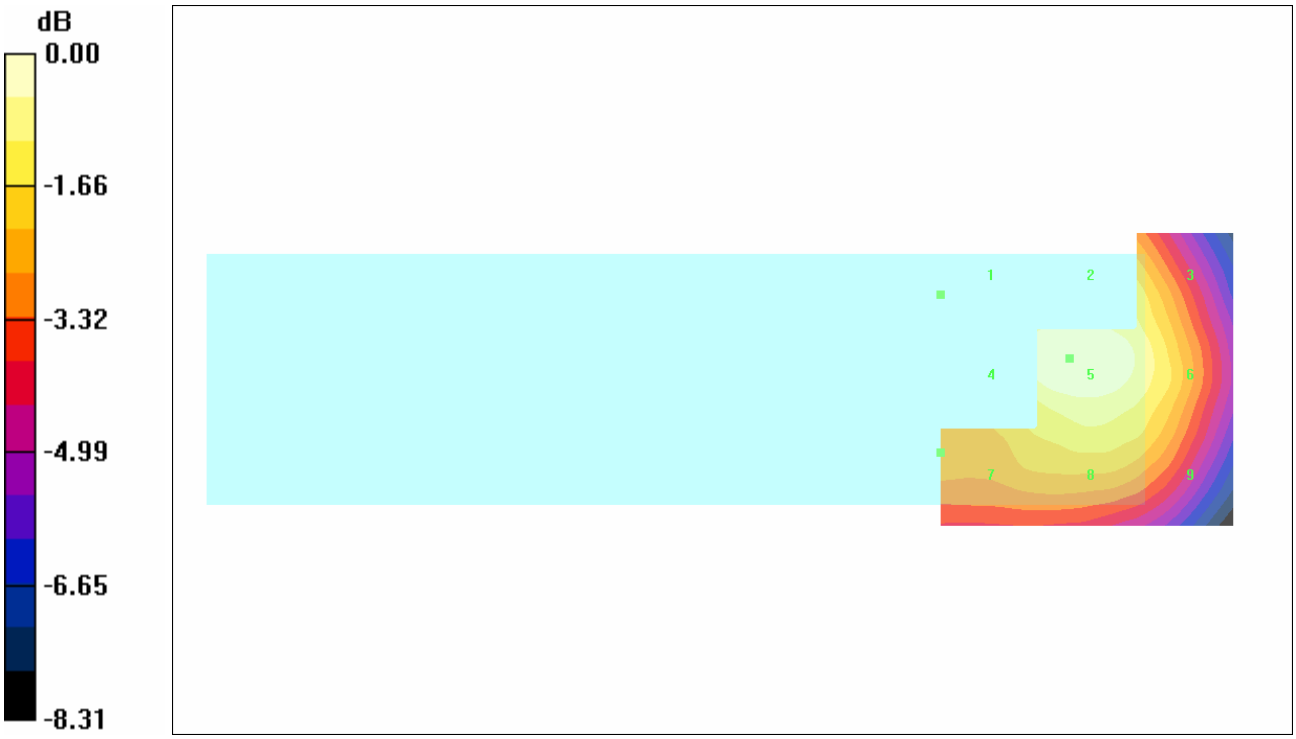
E in V/m (Time averaged)

Grid 1 **86.1**	Grid 2 **90.3**	Grid 3 **83.5**
Grid 4 **90.0**	Grid 5 **93.5**	Grid 6 **87.3**
Grid 7 **77.8**	Grid 8 **82.0**	Grid 9 **78.7**

E in V/m (Slot averaged)

Grid 1 **89.5**	Grid 2 **93.8**	Grid 3 **86.7**
Grid 4 **93.5**	Grid 5 **97.1**	Grid 6 **90.7**
Grid 7 **80.8**	Grid 8 **85.3**	Grid 9 **81.8**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 93.5V/m

Date/Time: 7/28/2005 12:33:40 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 836.49 MHz;Duty Cycle: 1:1.08
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 91.0 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

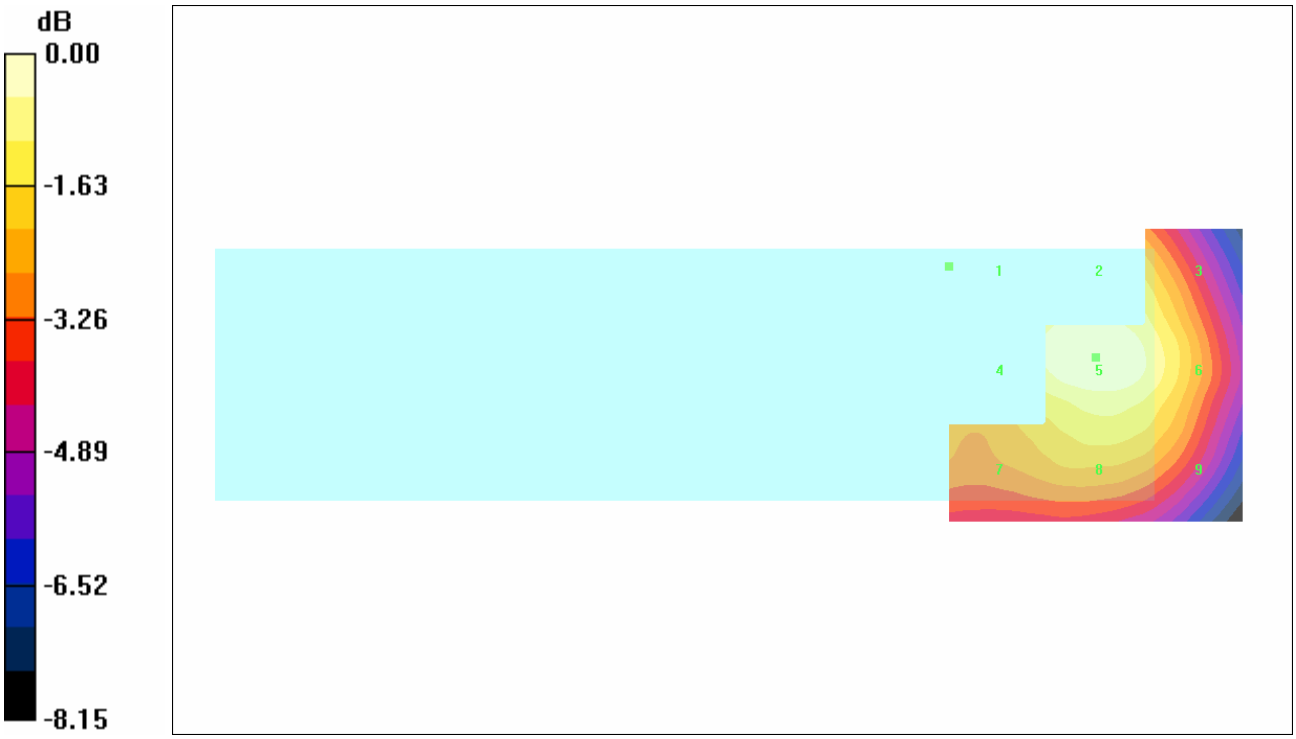
E in V/m (Time averaged)

Grid 1 **80.0**	Grid 2 **84.3**	Grid 3 **78.6**
Grid 4 **83.1**	Grid 5 **87.6**	Grid 6 **82.5**
Grid 7 **71.2**	Grid 8 **76.3**	Grid 9 **73.4**

E in V/m (Slot averaged)

Grid 1 **83.2**	Grid 2 **87.6**	Grid 3 **81.7**
Grid 4 **86.3**	Grid 5 **91.0**	Grid 6 **85.7**
Grid 7 **74.0**	Grid 8 **79.3**	Grid 9 **76.3**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 87.6V/m

Date/Time: 7/28/2005 12:42:23 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 848.31 MHz;Duty Cycle: 1:1.08
Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 85.8 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

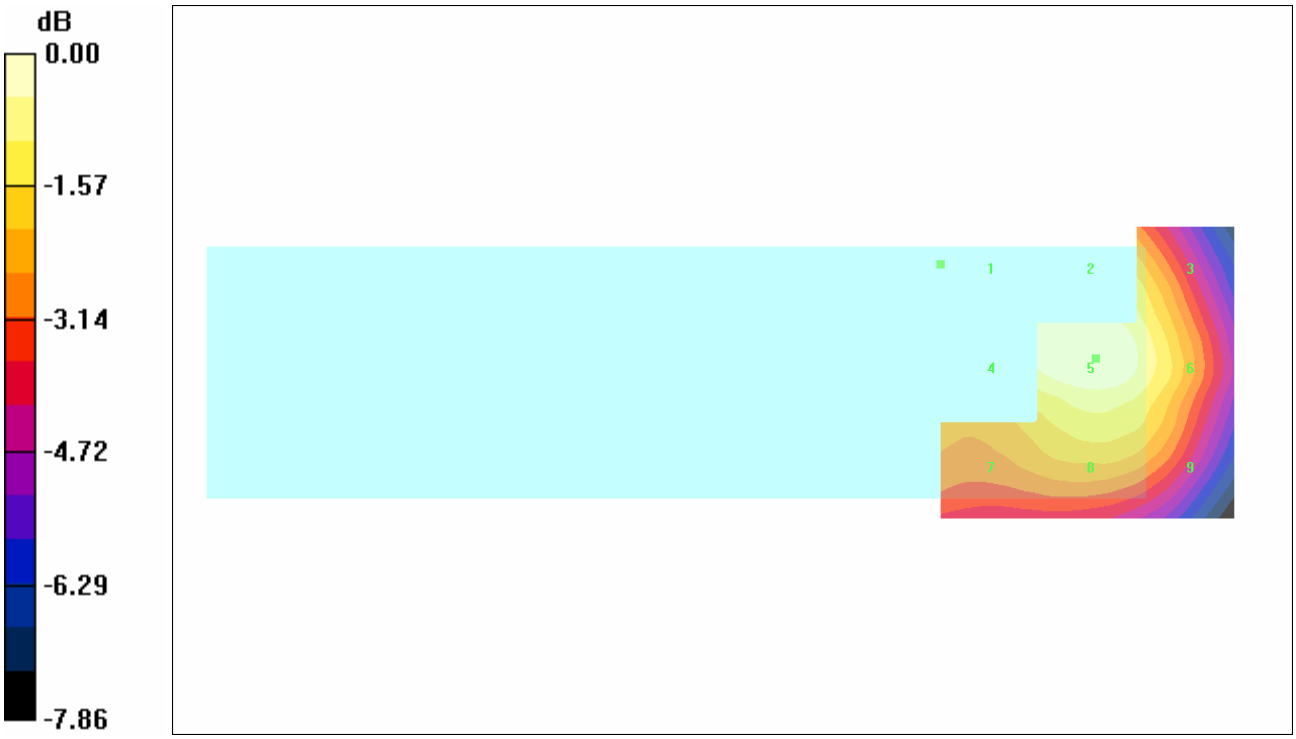
E in V/m (Time averaged)

Grid 1 **76.9**	Grid 2 **79.7**	Grid 3 **74.7**
Grid 4 **79.3**	Grid 5 **82.6**	Grid 6 **78.1**
Grid 7 **67.1**	Grid 8 **72.0**	Grid 9 **69.9**

E in V/m (Slot averaged)

Grid 1 **79.9**	Grid 2 **82.8**	Grid 3 **77.6**
Grid 4 **82.4**	Grid 5 **85.8**	Grid 6 **81.1**
Grid 7 **69.7**	Grid 8 **74.9**	Grid 9 **72.6**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 82.6V/m

Date/Time: 7/28/2005 1:37:04 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 824.7 MHz;Duty Cycle: 1:1.08
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 96.0 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

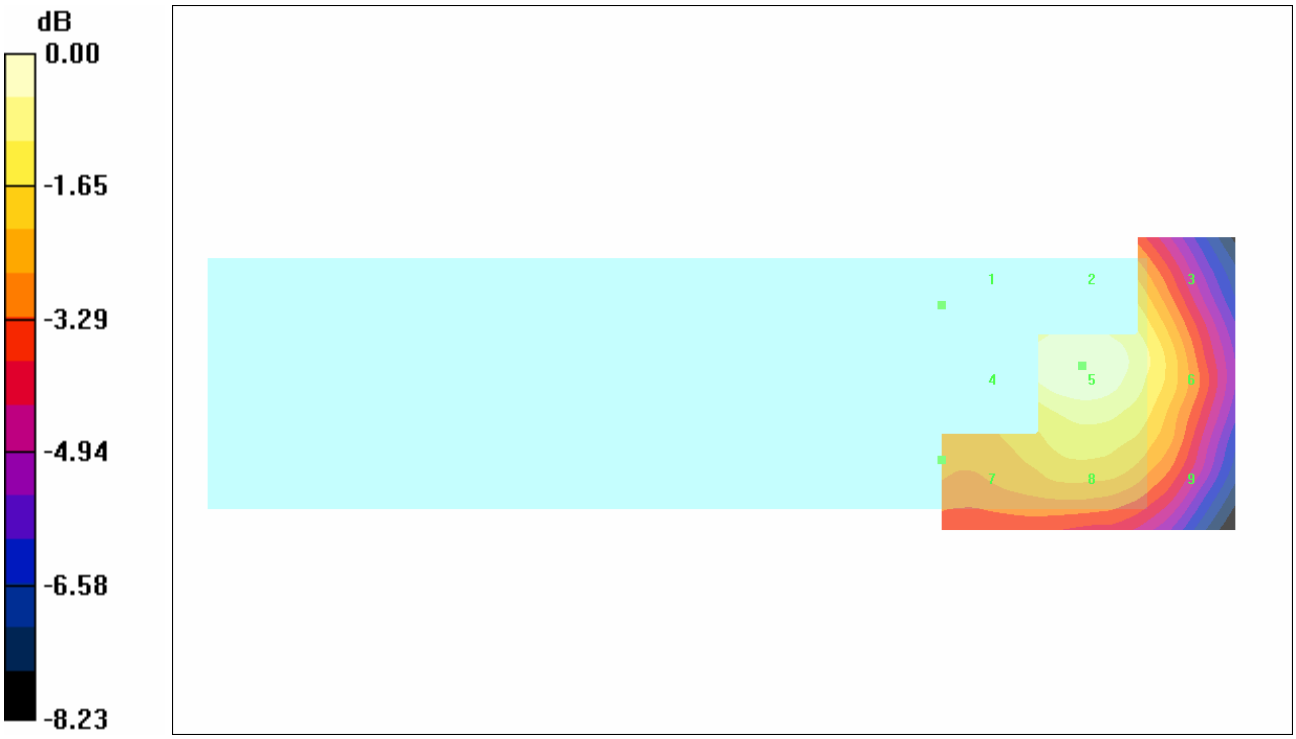
E in V/m (Time averaged)

Grid 1 **84.4**	Grid 2 **88.2**	Grid 3 **81.4**
Grid 4 **88.0**	Grid 5 **92.4**	Grid 6 **85.0**
Grid 7 **75.8**	Grid 8 **80.1**	Grid 9 **76.5**

E in V/m (Slot averaged)

Grid 1 **87.7**	Grid 2 **91.7**	Grid 3 **84.6**
Grid 4 **91.4**	Grid 5 **96.0**	Grid 6 **88.3**
Grid 7 **78.8**	Grid 8 **83.3**	Grid 9 **79.5**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 92.4V/m

Date/Time: 7/28/2005 1:45:25 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 836.49 MHz;Duty Cycle: 1:1.08
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of Total field (slot averaged) = 87.6 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

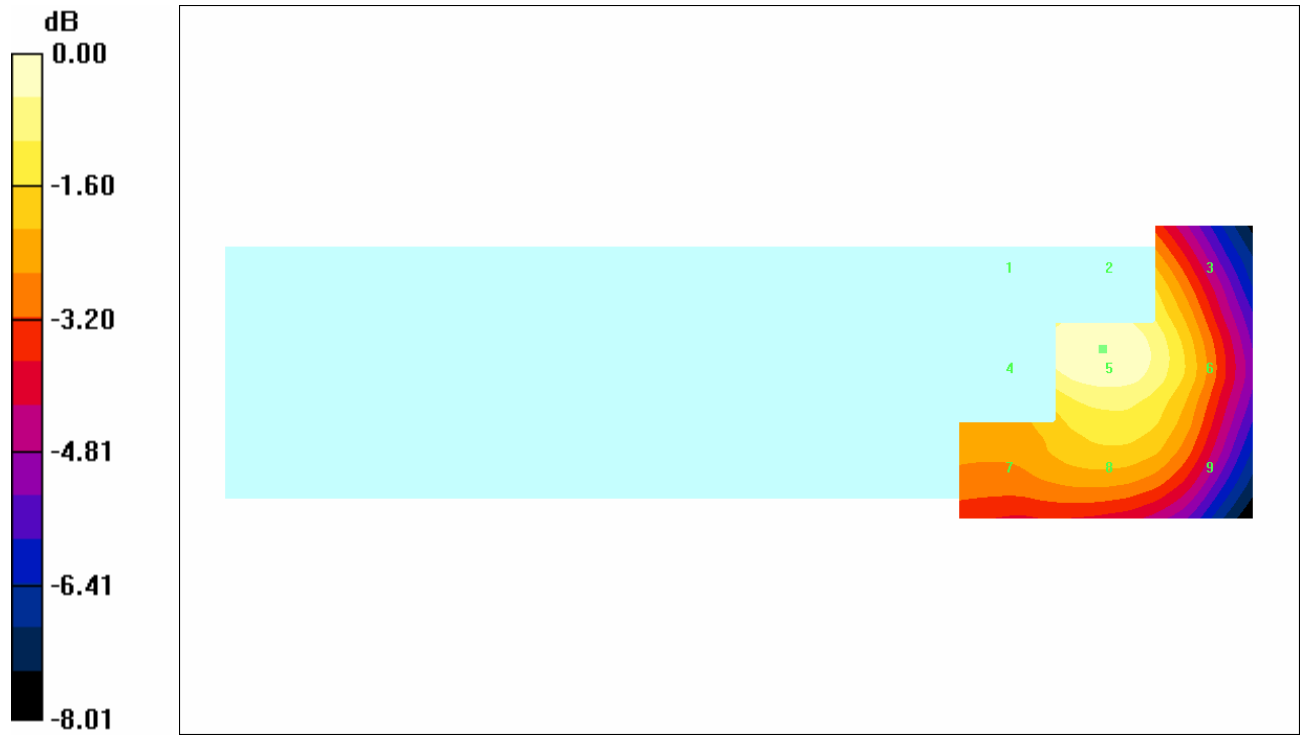
E in V/m (Time averaged)

Grid 1 **77.8**	Grid 2 **81.1**	Grid 3 **74.4**
Grid 4 **80.5**	Grid 5 **84.3**	Grid 6 **78.2**
Grid 7 **68.5**	Grid 8 **73.3**	Grid 9 **70.6**

E in V/m (Slot averaged)

Grid 1 **80.8**	Grid 2 **84.3**	Grid 3 **77.3**
Grid 4 **83.7**	Grid 5 **87.6**	Grid 6 **81.3**
Grid 7 **71.2**	Grid 8 **76.2**	Grid 9 **73.3**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 84.3V/m

Date/Time: 7/28/2005 1:51:19 PM

Test Laboratory: Compliance Certification Services

HAC_E_Device Cell band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA Cellular band; Frequency: 848.31 MHz;Duty Cycle: 1:1.08
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan -H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 84.9 V/m
Hearing Aid Near-Field Category: M3 (AWF 0 dB)

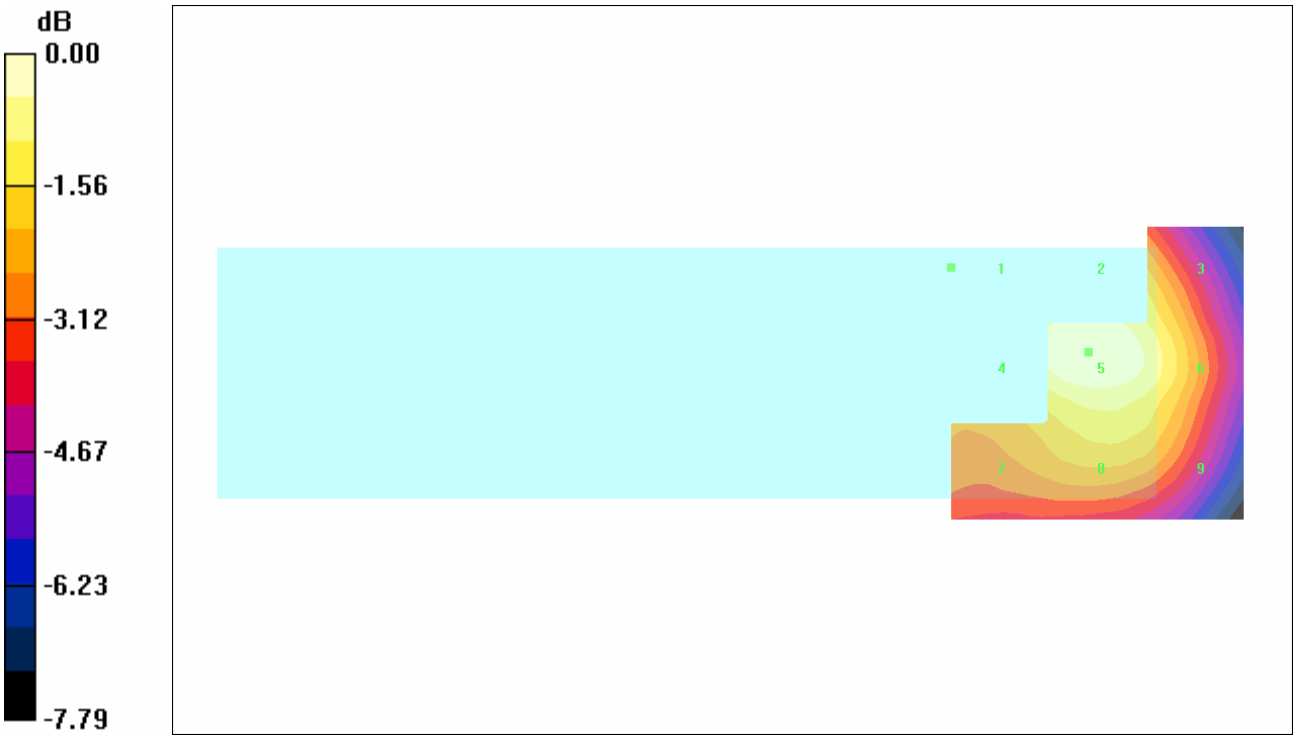
E in V/m (Time averaged)

Grid 1 **75.6**	Grid 2 **78.9**	Grid 3 **72.2**
Grid 4 **78.3**	Grid 5 **81.7**	Grid 6 **76.4**
Grid 7 **66.4**	Grid 8 **71.1**	Grid 9 **68.6**

E in V/m (Slot averaged)

Grid 1 **78.5**	Grid 2 **82.0**	Grid 3 **75.1**
Grid 4 **81.4**	Grid 5 **84.9**	Grid 6 **79.4**
Grid 7 **69.0**	Grid 8 **73.9**	Grid 9 **71.3**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 81.7V/m

Date/Time: 7/27/2005 11:42:18 AM

Test Laboratory: Compliance Certification Services

1_HAC_E_Device PCS band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1851.25 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 46.3 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

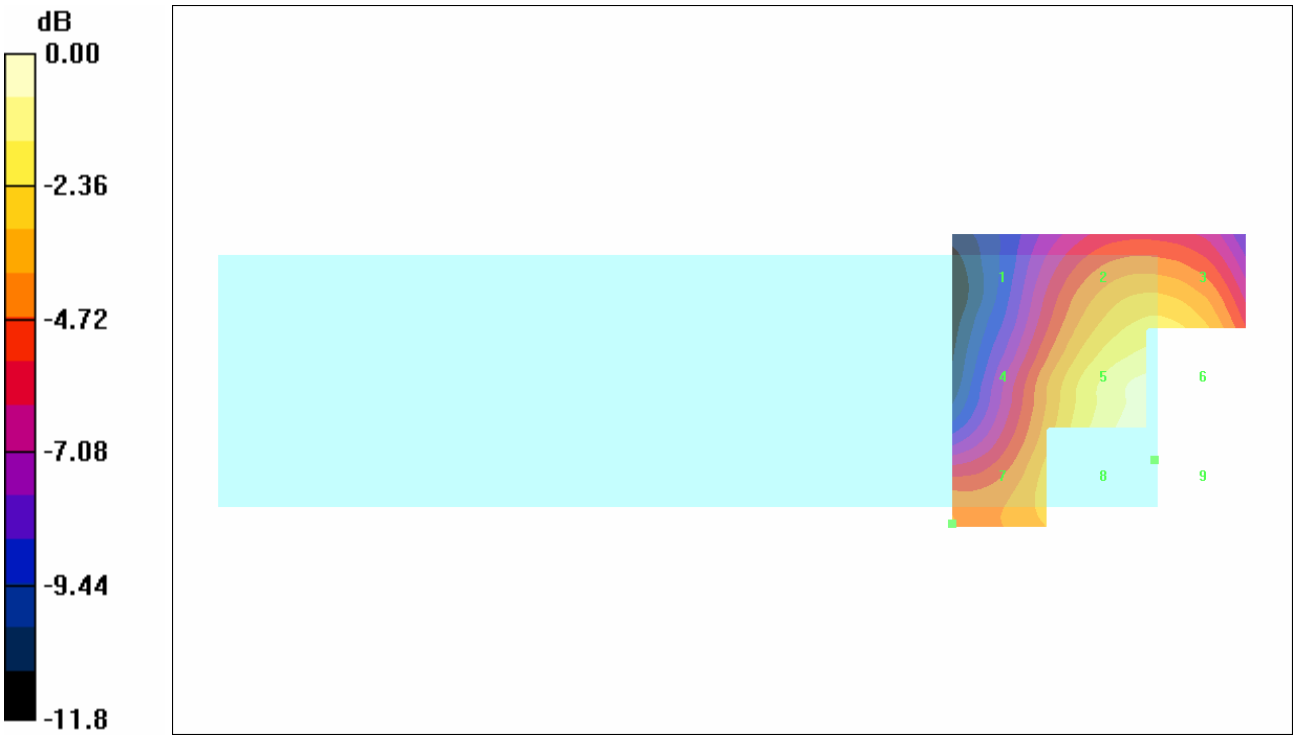
E in V/m (Time averaged)

Grid 1 **24.9**	Grid 2 **37.4**	Grid 3 **37.7**
Grid 4 **31.1**	Grid 5 **45.8**	Grid 6 **46.2**
Grid 7 **34.4**	Grid 8 **46.9**	Grid 9 **47.2**

E in V/m (Slot averaged)

Grid 1 **25.1**	Grid 2 **37.8**	Grid 3 **38.0**
Grid 4 **31.4**	Grid 5 **46.3**	Grid 6 **46.7**
Grid 7 **34.8**	Grid 8 **47.4**	Grid 9 **47.6**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 47.2V/m

Date/Time: 7/27/2005 11:48:00 AM

Test Laboratory: Compliance Certification Services

1_HAC_E_Device PCS band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1880 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 45.5 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

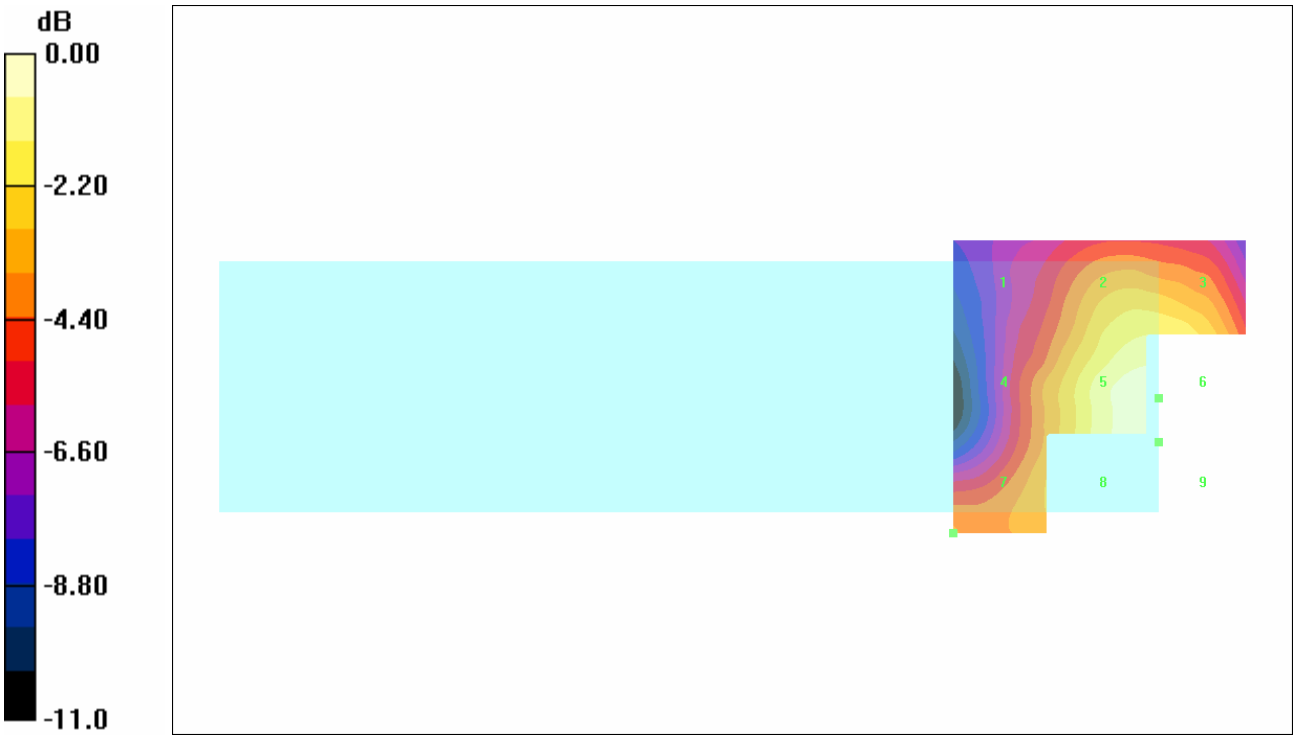
E in V/m (Time averaged)

Grid 1 **26.4**	Grid 2 **38.5**	Grid 3 **38.5**
Grid 4 **30.8**	Grid 5 **45.1**	Grid 6 **45.5**
Grid 7 **32.8**	Grid 8 **45.2**	Grid 9 **45.6**

E in V/m (Slot averaged)

Grid 1 **26.6**	Grid 2 **38.8**	Grid 3 **38.9**
Grid 4 **31.1**	Grid 5 **45.5**	Grid 6 **46.0**
Grid 7 **33.2**	Grid 8 **45.7**	Grid 9 **46.1**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 45.6V/m

Date/Time: 7/27/2005 11:53:50 AM

Test Laboratory: Compliance Certification Services

1_HAC_E_Device PCS band (Backlight on)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1908.75 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 40.8 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

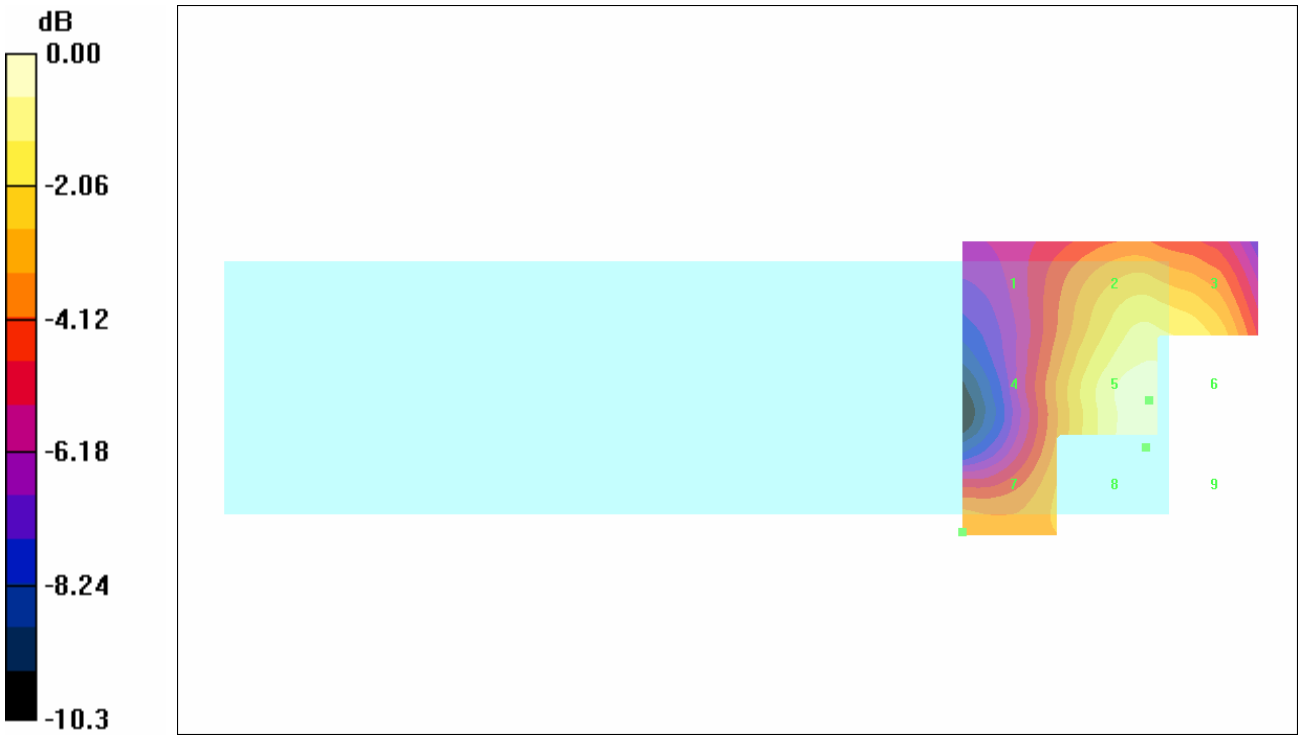
E in V/m (Time averaged)

Grid 1 **25.5**	Grid 2 **35.8**	Grid 3 **35.2**
Grid 4 **27.8**	Grid 5 **40.4**	Grid 6 **40.0**
Grid 7 **30.2**	Grid 8 **40.6**	Grid 9 **40.0**

E in V/m (Slot averaged)

Grid 1 **25.8**	Grid 2 **36.2**	Grid 3 **35.6**
Grid 4 **28.0**	Grid 5 **40.8**	Grid 6 **40.4**
Grid 7 **30.5**	Grid 8 **41.0**	Grid 9 **40.4**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 40.6V/m

Date/Time: 7/27/2005 12:10:13 PM

Test Laboratory: Compliance Certification Services

2_HAC_E_Device PCS band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1851.25 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - L-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 45.6 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

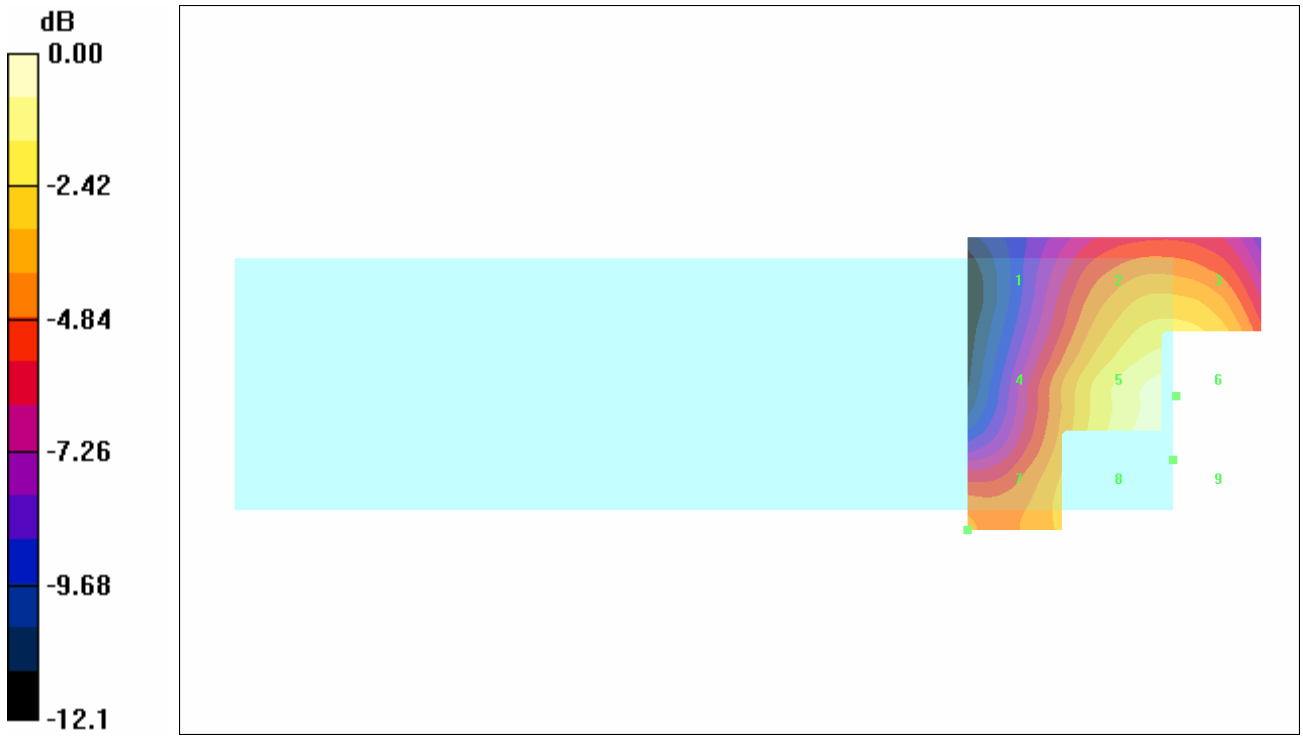
E in V/m (Time averaged)

Grid 1 **24.4**	Grid 2 **36.6**	Grid 3 **36.7**
Grid 4 **29.9**	Grid 5 **45.2**	Grid 6 **45.6**
Grid 7 **33.1**	Grid 8 **46.1**	Grid 9 **46.3**

E in V/m (Slot averaged)

Grid 1 **24.6**	Grid 2 **36.9**	Grid 3 **37.1**
Grid 4 **30.2**	Grid 5 **45.6**	Grid 6 **46.1**
Grid 7 **33.5**	Grid 8 **46.6**	Grid 9 **46.8**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 46.3V/m

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Test Laboratory: Compliance Certification Services

2_HAC_E_Device PCS band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1880 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - M-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 45.3 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

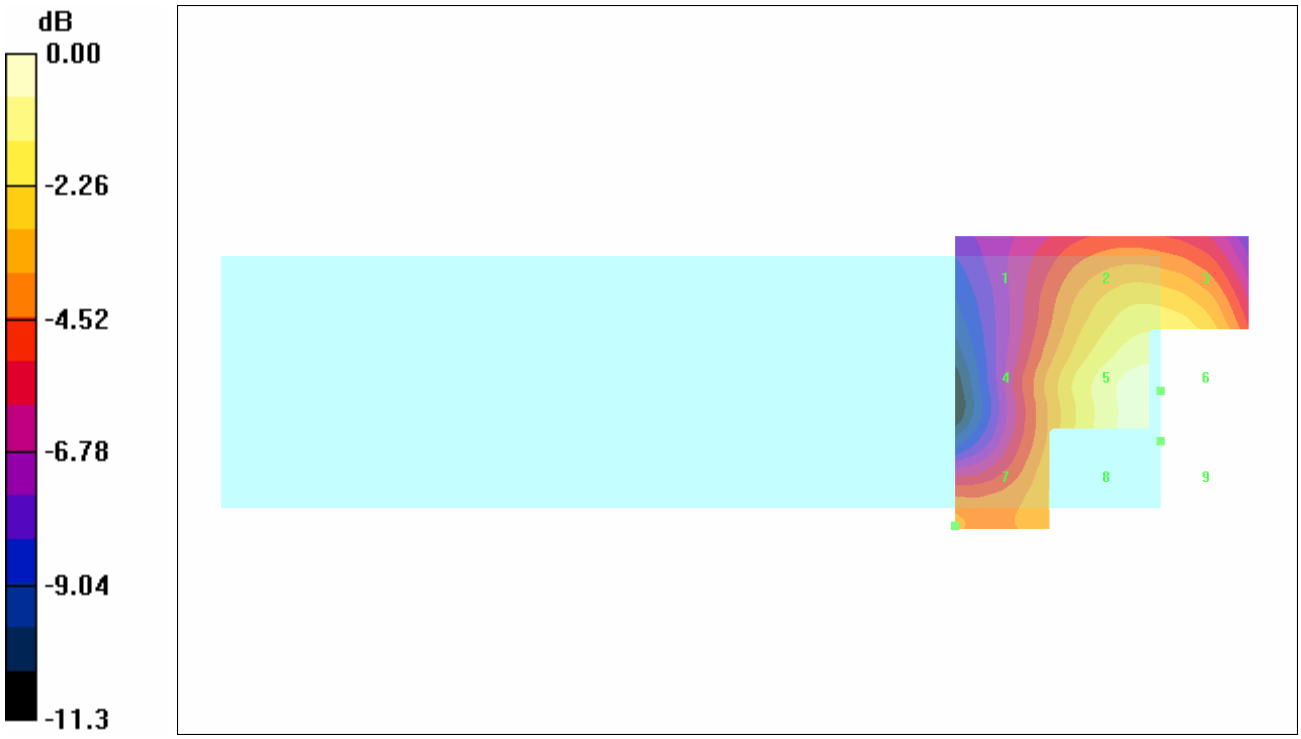
E in V/m (Time averaged)

Grid 1 **27.0**	Grid 2 **38.0**	Grid 3 **38.1**
Grid 4 **30.6**	Grid 5 **44.8**	Grid 6 **45.2**
Grid 7 **32.3**	Grid 8 **45.2**	Grid 9 **45.5**

E in V/m (Slot averaged)

Grid 1 **27.3**	Grid 2 **38.4**	Grid 3 **38.4**
Grid 4 **30.9**	Grid 5 **45.3**	Grid 6 **45.7**
Grid 7 **32.7**	Grid 8 **45.6**	Grid 9 **45.9**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 45.5V/m

Date/Time: 7/27/2005 12:22:52 PM

Test Laboratory: Compliance Certification Services

2_HAC_E_Device PCS band (Backlight off)

DUT: Kyocera; Type: KX1; Serial: 20-M4004-01B

Communication System: CDMA PCS band; Frequency: 1908.75 MHz;Duty Cycle: 1:1.02
Medium parameters used: σ = 0 mho/m, ε_r = 1; ρ = 1000 kg/m^3
Phantom section: E Device Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 - SN2339; ConvF(1, 1, 1); Calibrated: 3/11/2005
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn500; Calibrated: 2/7/2005
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.5 Build 19;

E Scan - H-ch/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm
Maximum value of Total field (slot averaged) = 41.7 V/m
Hearing Aid Near-Field Category: M4 (AWF 0 dB)

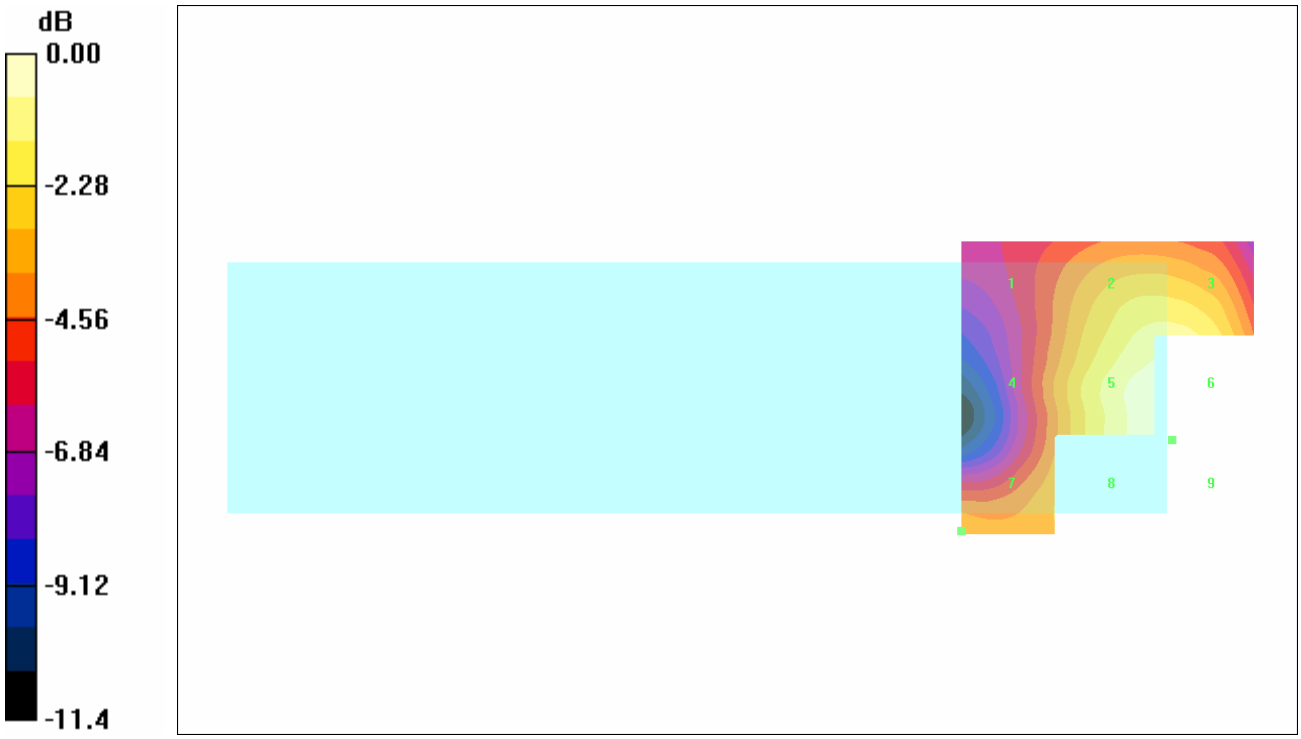
E in V/m (Time averaged)

Grid 1 **25.5**	Grid 2 **36.6**	Grid 3 **36.8**
Grid 4 **27.5**	Grid 5 **41.3**	Grid 6 **42.0**
Grid 7 **29.8**	Grid 8 **41.4**	Grid 9 **42.1**

E in V/m (Slot averaged)

Grid 1 **25.8**	Grid 2 **36.9**	Grid 3 **37.2**
Grid 4 **27.8**	Grid 5 **41.7**	Grid 6 **42.4**
Grid 7 **30.1**	Grid 8 **41.8**	Grid 9 **42.5**

Category	AWF (dB)	Limits for E-Field Emissions (V/m)	Limits for H-Field Emissions (A/m)
M1	0	199.5 - 354.8	0.6 - 1.07
	-5	149.6 - 266.1	0.45 - 0.8
M2	0	112.2 - 199.5	0.34 - 0.6
	-5	84.1 - 149.6	0.25 - 0.45
M3	0	63.1 - 112.2	0.19 - 0.34
	-5	47.3 - 84.1	0.15 - 0.25
M4	0	<63.1	<0.19
	-5	<47.3	<0.15



0 dB = 42.1V/m